

INTERNATIONAL STANDARD

NORME INTERNATIONALE



**Surface acoustic wave (SAW) and bulk acoustic wave (BAW) duplexers of assessed quality –
Part 2: Guidelines for the use**

**Duplexeurs à ondes acoustiques de surface (OAS) et à ondes acoustiques de volume (OAV) sous assurance de la qualité –
Partie 2: Lignes directrices d'utilisation**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**SURFACE ACOUSTIC WAVE (SAW) AND BULK
ACOUSTIC WAVE (BAW) DUPLEXERS
OF ASSESSED QUALITY –****Part 2: Guidelines for the use**

FOREWORD

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International Standard IEC 62604-2 has been prepared by IEC technical committee 49: Piezoelectric, dielectric and electrostatic devices and associated materials for frequency control, selection and detection.

This bilingual version (2019-10) corresponds to the monolingual English version, published in 2017-11.

This second edition cancels and replaces the first edition published in 2011. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- duplexers are described;
- duplexers with a balanced RX port are considered in the measurement method subclause (7.3).

NOTE In this standard, SAW and BAW duplexers are treated simultaneously because both duplexers are used in the same manner especially in mobile phone systems and have same requirements of characteristics, test method and so on.

The text of this International Standard is based on the following documents:

CDV	Report on voting
49/1217/CDV	49/1251/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62604 series, published under the general title *Surface acoustic wave (SAW) and bulk acoustic wave (BAW) duplexers of assessed quality*, can be found on the IEC website.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

SURFACE ACOUSTIC WAVE (SAW) AND BULK ACOUSTIC WAVE (BAW) DUPLEXERS OF ASSESSED QUALITY –

Part 2: Guidelines for the use

1 Scope

This part of IEC 62604 concerns duplexers which can separate receiving signals from transmitting signals and are key components for two-way radio communications, and which are generally used in mobile phone systems compliant with CDMA systems such as IS-CDMA in second generation mobile telecommunication systems (2G), W-CDMA / UTRAN (3G) or LTE (4G). While in 2G systems mainly dielectric duplexers have been used, the ongoing miniaturization in 3G and 4G mobile communication systems promoted the development and application of acoustic wave duplexers due to their small size, light weight and good electrical performance. While standard surface acoustic wave (SAW) duplexers have been employed for applications with moderate requirements regarding the steepness of individual filters, applications with narrow duplex gap (e.g. Bands 2, 3, 8, 25), i.e. the frequency gap between receiving and transmitting bands, require the application of temperature-compensated (TC) SAW or bulk acoustic wave (BAW) technology, because of their better temperature characteristics and resonator Q-factors.

It is neither the aim of these guidelines to explain the theory, nor to attempt to cover all the eventualities which may arise in practical circumstances. These guidelines draw attention to some of the more fundamental questions, which should be considered by the user before he places an order for SAW and BAW duplexers for a new application. Such a procedure will be the user's insurance against unsatisfactory performance. Because SAW and BAW duplexers have very similar performance for the user, it is useful and convenient for users that both duplexers are described in one standard.

Standard specifications, such as those of IEC, of which these guidelines form a part, and national specifications or detailed specifications issued by manufacturers will define the available combinations of centre frequency, pass bandwidth and insertion attenuation for each sort of transmitting and receiving filters and the isolation level between transmitter and receiver ports, etc. These specifications are compiled to include a wide range of SAW and BAW duplexers with standardized performances. It cannot be over-emphasized that the user should, wherever possible, select his duplexers from these specifications, when available, even if it may lead to making small modifications to his circuit to enable the use of standard duplexers. This applies particularly to the selection of the nominal frequency band.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60862-1:2015, *Surface acoustic wave (SAW) filters of assessed quality – Part 1: Generic specification*

IEC 62575-1:2015, *Radio frequency (RF) bulk acoustic wave (BAW) filters of assessed quality – Part 1: Generic specification*